Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/749,919	YAN ET AL.	
Examiner	Art Unit	
Y J Han	2838	

SEARCHED					
Class	Subclass	Date	Examiner		
363	17		1		
	56.02				
	56.03				
	56.04				
	56.05				
	56.12				
:	98				
	132				
323	252				
	333				
	363				
363	58	5/05	9A		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
363	56.02				
	132				
	98	5/05	A		
323/363		5/05	9A		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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